


<b>Search Notes</b>  	<b>Application/Control No.</b>  10519304	<b>Applicant(s)/Patent Under Reexamination</b>  WEIST ET AL.
	<b>Examiner</b>  LIEN T NGO	<b>Art Unit</b>  3754

SEARCHED			
Class	Subclass	Date	Examiner
222	83,83.5,80,81,82,87	3/11/08	LN
220	277,278, 265-267		

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner